SN54F245, SN74F245 OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SDFS010A - MARCH 1987 - REVISED OCTOBER 1993

- 3-State Outputs Drive Bus Lines Directly
- Package Options Include Plastic Small-Outline (SOIC) and Shrink Small-Outline (SSOP) Packages, Ceramic **Chip Carriers, and Plastic and Ceramic** DIPs

description

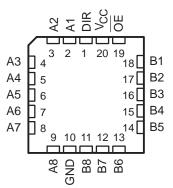
These octal bus transceivers are designed for asynchronous communication between data buses. The devices transmit data from the A bus to the B bus or from the B bus to the A bus depending upon the logic level at the direction-control (DIR) input. The output enable (\overline{OE}) input can be used to disable the device so the buses are effectively isolated.

The SN74F245 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54F245 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74F245 is characterized for operation from 0°C to 70°C.

SN54F245 J PACKAGE							
SN74F245 DB, D\	N, OR N PACKAGE						
(TOP V	'IEW)						

SN54F245 ... FK PACKAGE (TOP VIEW)



FUNCTION TABLE

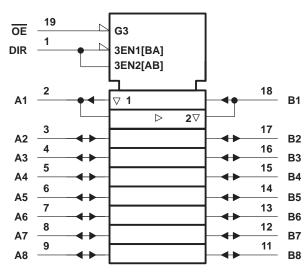
INP	UTS	OPERATION				
OE	DIR	OPERATION				
L	L	B data to A bus				
L	Н	A data to B bus				
Н	Х	Isolation				

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

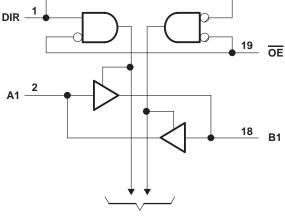
SN54F245, SN74F245 OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SDFS010A - MARCH 1987 - REVISED OCTOBER 1993

logic symbol[†]



logic diagram (positive logic)



To Seven Other Channels

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC} Input voltage range, V _I (except I/O port Input current range	s) (see Note 1)	1.2 V to 7 V
Voltage range applied to any output in t		
Voltage range applied to any output in t	•	
Current into any output in the low state	: SN54F245 (A1 thru A8)	40 mA
	SN54F245 (B1 thru B8)	
	SN74F245 (A1 thru A8)	48 mA
		128 mA
Operating free-air temperature range:		–55°C to 125°C
	SN74F245	0°C to 70°C
Storage temperature range		65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.



recommended operating conditions

			SN54F245			SN74F245			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH			2			2			V
VIL	Low-level input voltage				0.8			0.8	V
IIК	Input clamp current				-18			-18	mA
1		A1 thru A8			- 3			- 3	mA
ЮН	High-level output current	B1 thru B8			- 12			- 15	mA
1.0.1	Level and a devidence and a second	A1 thru A8			20			24	mA
IOL	Low-level output current B1 thru B8				48			64	ma
ТА	Operating free-air temperature		-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	ER TEST CONDITIONS		SN54F245			S					
P/			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT		
VIK		V _{CC} = 4.5 V,	lj = -18 mA			-1.2			-1.2	V	
	A1 thru A8	V _{CC} = 4.5 V	I _{OH} = – 1 mA	2.5	3.4		2.5	3.4			
	AT UITU A6	VCC = 4.5 V	I _{OH} = – 3 mA	2.4	3.3		2.4	3.3			
∨он	B1 thru B8		I _{OH} = – 12 mA	2	3.2					V	
	BT thru Bo	V _{CC} = 4.5 V	I _{OH} = – 15 mA				2	3.1			
	Any output	V _{CC} = 4.75 V,	$I_{OH} = -1 \text{ mA to} - 3 \text{ mA}$				2.7				
	A1 thru A8	V _{CC} = 4.5 V	I _{OL} = 20 mA		0.3	0.5				5 V	
Val	AT tillu Ao	VCC = 4.5 V	I _{OL} = 24 mA					0.35	0.5		
VOL	OL B1 thru B8	V _{CC} = 4.5 V	I _{OL} = 48 mA		0.38	0.55				v	
	BT thru Bo	VCC = 4.5 V	I _{OL} = 64 mA					0.42	0.55		
i.	A and B		VI = 5.5 V			1			1	mA	
Ι	DIR, OE	V _{CC} = 5.5 V	V _I = 7 V			0.1			0.1	MA	
. +	A and B	V _{CC} = 5.5 V,	V _I = 2.7 V			70			70	- uA	
чн‡	DIR, OE	VCC = 5.5 V,	V = 2.7 V			20			20		
. +	A and B	V _{CC} = 5.5 V,	V ₁ = 0.5 V			-0.65			-0.65	mA	
'⊪_‡	DIR, OE	VCC = 5.5 V,	v] = 0.5 v			- 1.2			- 1.2	ША	
laað	A1 thru A8		$\lambda = 0$	-60		-150	-60		-150	mA	
los§	B1 thru B8	V _{CC} = 5.5 V,	$V_{O} = 0$	-100		-225	-100		-225	mA	
		V _{CC} = 5.5 V	Outputs high		70	90		70	90		
ICC			Outputs low		95	120		95	120	mA	
	Outputs d		Outputs disabled		85	110		85	110		

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C.
[‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.
§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.



SN54F245, SN74F245 OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SDFS010A - MARCH 1987 - REVISED OCTOBER 1993

switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	Cl Rl	C = 5 V = 50 pl = 500 9 = 500 9 = 25°C	F, Ω,	CL RL	= 50 pF = 500 Ω			UNIT	
		′F245			F245	SN74F245					
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
^t PLH	A or B	B or A	1.7	3.8	6	1.2	7.5	1.7	7	ns	
^t PHL	AUD	BUIA	1.7	4.2	6	1.2	7.5	1.7	7	115	
^t PZH	ŌĒ	A or B	2.2	4.9	7	1.7	9	2.2	8	ns	
^t PZL	UE	AUID	2.7	5.6	8	2.2	10	2.7	9	115	
^t PHZ	ŌĒ	A or B	2.2	4.6	6.5	1.7	9	2.2	7.5	20	
^t PLZ			1.2	4.6	6.5	1.2	10	1.2	7.5	ns	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Load circuits and waveforms are shown in Section 1.



IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated